

# Nonlinear diffusivity dependence on dimensions

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**Abstract.** The nonlinear diffusion equation corresponds to the diffusion processes which can occur with a finite velocity. This statement is not satisfied in Fick's second law or linear diffusion equation. The processes by which different materials mix in the result of the random Brownian motions of atoms, molecules and ions can be exactly described only with presented nonlinear equation. It was important in practice that theoretically profiles fit with the experimental profiles tail region, but get good coincidence between diffusion experiments and the classical solutions is impossible. By using obtained theoretical solutions for two and three-dimensional cases we can provide more exact modeling of all the stages of a planar transistor formation.

**Keywords:** nonlinear diffusion equation, diffusion coefficients in higher dimensional, approximate analytical solution.

## Introduction

In 1983, A.J. Janavičius proposed nonlinear diffusion equation which played an important role in theoretical and practical applications to technological processes of electronic devices and micro schemes [10, 14]. Here obtained approximate analytical solutions [14] were in good fitting with diffusion experiments in silicon. In 1984 M. Sapagovas with collaborators [3] considered nonlinear diffusion using numerical methods. The nonlinear theory accepted that diffusion processes must occur with finite velocity [1]. For this case diffusion coefficient must be directly proportional to the concentration of the impurities [5]. The equation was solved for excited atoms irradiated by X-rays and a new physical phenomenon such as impurities superdiffusion at room temperature in the crystals was found [2, 6] and verified experimentally [2]. We obtained important connections between higher dimensional and nonlinear diffusion coefficients and solutions by considering nonlinear diffusion through a square window in [4] two and three-dimensional cases. The root-mean-square displacement of the diffusion cloud [4]

$$\langle R_d^2 \rangle^{\frac{1}{2}} = \sqrt{2dD_d t}, \quad (1)$$

must be consented with Einstein expression for diffusion coefficient [4]

$$D_d = \frac{1}{2d} \Gamma_d \lambda^2. \quad (2)$$

$\Gamma_d$  is diffusing particles jumping frequency in  $d$  dimensions,  $t$  is diffusion time. Statistical mechanics describes a sequence of unpredictable movement called a random walk. The rules of random walk can be simplified into one-dimensional random jumping of particles with constant frequencies. The displacements of particles after  $n+1$ -th jump of the length  $\lambda$  are

$$x_{n+1} = x_n \pm \lambda. \tag{3}$$

Taking both sides of this equation in square and overriding by a number of particles, requiring that the overage displacement  $\langle x_n \rangle = 0$ , we obtain

$$\langle x_{n+1}^2 \rangle = \langle x_n^2 \rangle + \lambda^2, \quad \langle x_n^2 \rangle = N\lambda^2. \tag{4}$$

Accepting that the mean time  $\tau$  of jumps of diffusing particles in the homogeneous matter must be constant for different stages of diffusion, we can get expression of the number of jumps  $N = \frac{t}{\tau}$  for diffusion process duration time  $t$ . Then mean-square displacement and path of diffusion can be determined by

$$\langle x_n^2 \rangle = \lambda^2 \Gamma t, \quad x_d = \sqrt{\langle x_n^2 \rangle} = \sqrt{\lambda^2 \Gamma t}. \tag{5}$$

If the particle is hopping in the random way the path of diffusion is proportional to the square root of the diffusion time. We can see that diffusion coefficient depends on frequency and length of jumps and geometry of task. The diffusion coefficients for diffusion in one  $D_1$ , two  $D_2$  and three  $D_3$  dimensional cases and paths of diffusion  $x_d$  can be expressed [4] in homogeneous environment

$$D_1 = \frac{1}{2}\lambda^2\Gamma, \quad D_2 = \frac{1}{4}\lambda^2\Gamma, \quad D_3 = \frac{1}{6}\lambda^2\Gamma, \quad x_d = \sqrt{2dD_d t}. \tag{6}$$

For a symmetric case of jumps' length  $\lambda$ , frequencies  $\Gamma$  of diffusing particles and diffusion path  $x_d$  does not depend on dimensions number. The diffusion coefficients  $D = D_1$  for linear diffusion equation [4] for one-dimensional case

$$\frac{\partial}{\partial t} N = D \frac{\partial^2}{\partial x^2} N, \quad D = D_0 e^{-\frac{E}{kT}} \tag{7}$$

depend on exponential factor  $D_0$ , temperature  $T$ , Boltsmann's constants  $k$  and excitation energy  $E$  of diffusing atoms. The diffusion coefficient  $D$  for one-dimensional case in semiconductors can be defined from impurities profiles [5] or  $p - n$  junctions' depths [8]. The experimental profile tail regions and theoretical solutions of linear diffusion equation cannot be fitted [10, 5]. The aim of the article is more exact definition of  $p - n$  depths and thickness of planar diodes and transistors [8].

## 1 Nonlinear diffusion in one-dimensional case

The parameters of microelectronics can be sufficiently exactly defined by nonlinear diffusion equation [10] and impurities flux  $J$  [5] of thermodiffusion in silicon

$$\frac{\partial}{\partial t} N = \frac{\partial}{\partial x} \left( D(N) \frac{\partial}{\partial x} N \right), \quad J = -D(N) \frac{\partial}{\partial x} N(x), \quad D(N) = \frac{N(x)}{N_S}. \tag{8}$$

The nonlinear diffusion coefficient is directly proportional to concentration of the impurities [10] and defined by impurities concentration  $N_S$  at the source. This model includes the physically realistic model according to which the impurities flux  $J$ , rewritten by the discretiation method [7], differs from zero at the point  $x + \Delta x$  only if impurities are present at the point  $x$ . The latter equation means that the length of the jump of diffusing particles from the point  $x$  to  $x + \Delta x$  in the diffusion process is not greater than  $\Delta x$  and the jump is possible only when a diffusing particle exists at the point  $x$ .

Now we will present a similarity solution [7] of the nonlinear diffusion equation (8) satisfying the boundary and initial conditions

$$N(0, t \geq 0) = N_S, \quad N(\infty, t) = 0, \quad N(x, 0) = 0, \quad x > 0. \quad (9)$$

Introducing the similarity variable [4]

$$\xi = \frac{x}{\sqrt{D_s t}}, \quad D_s = D_n N_s, \quad D_n = D(N) \quad (10)$$

and  $N(x, t) = N_s f(\xi)$ , into (8) we obtained equation for solution satisfying conditions (9)

$$2 \frac{d}{d\xi} \left( f \frac{d}{d\xi} f \right) + \xi \frac{d}{d\xi} f = 0, \quad f(\xi) = \sum_{n=0}^m a_n \xi^n, \quad a_0 = 1. \quad (11)$$

Then solution with included terms until fourth power  $m = 4$  was expressed [5]

$$\begin{aligned} N_4 &= N_s (1 - 0.44\xi - 0.098\xi^2 - 6.67 \times 10^{-3}\xi^3 + 4.002 \times 10^{-4}\xi^4), \\ \xi_{04} &= 1.62, \quad x_{04} = \xi_{04} \sqrt{N_s D_n t}, \quad 0 \leq x \leq x_{04}, \\ x_{04} &= \xi_{04} \sqrt{D_s t}, \quad D_s = N_s D_n. \end{aligned} \quad (12)$$

The obtained approximate solutions satisfy boundary and initial (9) conditions and sufficient good coincidence [3] with  $\xi_0 = 1.64$ . The obtained maximum penetration depths of impurities (12) are proportional to  $\sqrt{t}$  and coincide with Brownian movement theory [4]. Substituting  $\xi_{04}$  into  $N_4$  we got  $1.71 \times 10^{-3}$ , whence we see that the roots  $\xi_{04}$  and the solutions  $N_4$  are obtained with sufficient accuracy.

## 2 Nonlinear diffusion in three-dimensional case

Rewriting equation (12) and using [2, 4] we obtained a nonlinear diffusion equation in the three-dimensional case

$$\frac{\partial}{\partial t} N = \frac{\partial}{\partial x} \left( (D(N)) \frac{\partial}{\partial x} N \right) + \frac{\partial}{\partial y} \left( (D(N)) \frac{\partial}{\partial y} N \right) + \frac{\partial}{\partial z} \left( (D(N)) \frac{\partial}{\partial z} N \right), \quad (13)$$

$$D(N) = \frac{1}{N_S} D N(x, y, z, t), \quad N_2 = N(x, y, t), \quad N_3 = N(x, y, z, t) \quad (14)$$

with diffusion coefficients  $D(N)$  defined as  $D(N_2)$  in the  $x, y$  plane and  $D(N_3)$  according to  $z$  axis when off-diagonal elements equal zero [4]. Stochastic jumps of particles can occur according to orthogonal directions in the  $x, y$  and  $z$  axis. It can happen in crystals with diamond type lattice [4].

The equation (8) will be solved by introducing similarity variables [4]

$$\begin{aligned} \xi_1 &= \frac{|x| - h}{\sqrt{Dt}}, & \xi_2 &= \frac{|y| - h}{\sqrt{Dt}}, & \xi_3 &= \frac{z}{\sqrt{Dt}}, \\ h \leq |x| \leq x_0, & & h \leq |y| \leq y_0, & & 0 \leq z \leq z_0, & & z_0 = \xi_{30}\sqrt{Dt}, \\ 0 \leq \xi_1 \leq \xi_{10}, & & 0 \leq \xi_2 \leq \xi_{20}, & & 0 \leq \xi_3 \leq \xi_{30}, & & \\ x_0 = \xi_{10}\sqrt{Dt} + h, & & y_0 = \xi_{20}\sqrt{Dt} + h, & & & & \end{aligned} \tag{15}$$

for two-dimensional  $N_2 = N(\xi_1, \xi_2)$  or three-dimensional case  $N_3 = N(\xi_1, \xi_2, \xi_3)$  consequently describing the square source with the diagonals length  $2h$  with defined corners  $(x_0, y_0)$  at  $z = 0$ .

For solution of (8) expressed in new similarity variables

$$\begin{aligned} N(x, y, z, t) &= N_S f(\xi_{1d}, \xi_{2d}, \xi_{3d}), \\ \sum_{i=1}^3 \left( 2 \frac{\partial}{\partial \xi_{id}} \left( f \frac{\partial f}{\partial \xi_{id}} \right) + \xi_{id} \frac{\partial f}{\partial \xi_{id}} + \xi_{i0} \frac{\partial f}{\partial \xi_{id}} \right) &= 0, \tag{16} \\ \xi_{1d} = \xi_1 - \xi_{10}, & & \xi_{2d} = \xi_2 - \xi_{20}, & & \xi_{3d} = \xi_3 - \xi_{30}, \\ -\xi_{10} \leq \xi_{1d} \leq 0, & & -\xi_{20} \leq \xi_{2d} \leq 0, & & -\xi_{30} \leq \xi_{3d} \leq 0, \end{aligned} \tag{17}$$

we will use the approximate Taylor power expansion [7] at maximum penetration points  $\xi_{10}, \xi_{20}, \xi_{30}$  of impurities.

The solution  $f(\xi_1, \xi_2, \xi_3)$  of (16) can be presented by the Taylor series by expansion [13]

$$\begin{aligned} f(\xi_1, \xi_2, \xi_3) &= f(P_0) + \sum_{i=1}^3 (\xi_i - \xi_{i0}) \frac{\partial f}{\partial \xi_i} \Big|_{P_0} + \frac{1}{2!} \sum_{i=1}^3 \sum_{j=1}^3 (\xi_i - \xi_{i0})(\xi_j - \xi_{j0}) \frac{\partial^2 f}{\partial \xi_i \partial \xi_j} \Big|_{P_0} \\ &+ R_3. \end{aligned} \tag{18}$$

at the same point  $P_0 = P_0(\xi_{10}, \xi_{20}, \xi_{30})$  where we included boundary condition  $f(P_0) = 0$  and dropped the terms  $R_3$  of order 3 and higher. Then we have

$$f(\xi_{1d}, \xi_{2d}, \xi_{3d}) = \sum_{i=1}^3 (a_i \xi_{id} + a_{i+3} \xi_{id}^2) + a_7 \xi_{1d} \xi_{2d} + a_8 \xi_{1d} \xi_{3d} + a_9 \xi_{2d} \xi_{3d}, \quad 0 \leq f \leq 1. \tag{19}$$

Substituting (19) into (16) and equating collected coefficients at  $\xi_{id}^n$ , with  $n = 0, 1; i = 1, 2, 3$  to zero and using boundary conditions

$$f(-\xi_{10}, -\xi_{20}, -\xi_{30}) = 1, \quad \xi_1 = 0, \quad \xi_2 = 0, \quad \xi_3 = 0, \tag{20}$$

$$f(0, -\xi_{20}, -\xi_{30}) = 0, \quad \xi_1 = \xi_{10}, \quad \xi_2 = 0, \quad \xi_3 = 0, \tag{21}$$

$$f(-\xi_{10}, -\xi_{20}, 0) = 0, \quad \xi_1 = 0, \quad \xi_2 = 0, \quad \xi_3 = \xi_{30}, \tag{22}$$

we define relative concentration of impurities in the center of the square (20) displaced in the  $x, y$  plane and zero concentration at the maximum penetration depths  $\xi_{10}, \xi_{20}, \xi_{30}$ , according to the coordinate axes  $x, y, z$  (21), (22) consequently. Then including the symmetry  $f(\xi_1, \xi_2, \xi_3) = f(\xi_1, \xi_2, \xi_3)$  of solution for the square source (2) we obtained

$$\xi_{10} = \xi_{20}, \quad a_1 = a_2, \quad a_4 = a_5, \quad a_8 = a_9. \tag{23}$$

Requiring that solution (19) must satisfy nonlinear equation (16) and boundary conditions (20), (21), (22) we got the following system of equations:

$$4a_1^2 + 2a_3^2 + 2\xi_{10}a_1 + \xi_{30}a_3 = 0, \quad (24)$$

$$a_1 + 16a_1a_4 + 4a_1a_7 + 4a_3a_8 + 4a_1a_6 + 2\xi_{10}a_4 + \xi_{30}a_8 + \xi_{10}a_7 = 0, \quad (25)$$

$$a_7 + 12a_4a_7 + 2a_6a_7 + 2a_8^2 = 0, \quad (26)$$

$$a_3 + 8a_1a_8 + 8a_3a_4 + 12a_3a_6 + 2\xi_{10}a_8 + 2\xi_{30}a_6 = 0, \quad (27)$$

$$a_8(1 + 8a_4 + 2a_7 + 6a_6) = 0, \quad (28)$$

$$-2a_1\xi_{10} - a_3\xi_{30} + 2a_4\xi_{10}^2 + a_6\xi_{30}^2 + a_7\xi_{10}^2 + 2a_8\xi_{10}\xi_{30} = 1, \quad (29)$$

$$-\xi_{10}a_1 - \xi_{30}a_3 + a_4\xi_{10}^2 + a_6\xi_{30}^2 + a_8\xi_{10}\xi_{30} = 0, \quad (30)$$

$$-2a_1 + 2\xi_{10}a_4 + \xi_{10}a_7 = 0. \quad (31)$$

The first five equations are obtained by equating the collected terms at constant, and at  $(\xi_1 - \xi_{10})$ ,  $(\xi_1 - \xi_{10})(\xi_2 - \xi_{20})$ ,  $(\xi_3 - \xi_{30})$ ,  $(\xi_1 - \xi_{10})(\xi_3 - \xi_{30})$  consequently. We got the last three equations (29), (30), (31) requiring to satisfy the boundary conditions (20)–(22). Equations we solved by using the computer algebra system Maple 14. The following meanings of constants for (19) was found

$$\begin{aligned} a_1 = a_2 = 0, \quad a_3 = -0.745356, \quad a_4 = a_5 = -0.075000, \quad a_6 = -0.050000, \\ a_7 = 0.150000, \quad a_8 = a_9 = 0, \quad \xi_{10} = \xi_{20} = 3.65148, \quad \xi_{30} = 1.49071. \end{aligned} \quad (32)$$

Then approximate solution of (19) can be represented

$$f(\xi_{1d}, \xi_{2d}, \xi_{3d}) = a_3\xi_{3d} + a_4\xi_{1d}^2 + a_4\xi_{2d}^2 + a_6\xi_{3d}^2 + a_7\xi_{1d}\xi_{2d}. \quad (33)$$

This solution does not satisfy conditions (6) for diffusion coefficients and paths for different dimensions. The presented results can be applied in inhomogeneous environment.

We can compare obtained solution with the same boundary conditions (14) using in power expansion essentially different variables  $\xi_i^1 = \frac{\xi_i}{\xi_{i0}}$  until square terms were obtained as close solutions  $\xi_{10}^1 = \xi_{20}^1 = 4$  and  $\xi_{30}^1 = 1.42$ . Here correlation term  $\xi_1\xi_2$  as in (31) was not included and for this reason our solutions for  $\xi_{10}$ ,  $\xi_{20}$ ,  $\xi_{30}$  are more exact than values  $\xi_{10}^1$ ,  $\xi_{20}^1$ ,  $\xi_{30}^1$ . The terms  $\xi_{30} = 1.49$  and  $\xi_{30}^1 = 1.42$  coincide with sufficient accuracy.

Similar expansion in power series  $(\xi - \xi_0)^n$  for solution of one-dimensional case of the nonlinear diffusion equation (11) gives the fast convergence of solution and maximum values  $\xi_{n0}$  for finite  $n$  [9]

$$\xi_{10} = \sqrt{2}, \quad \xi_{20} = 1.633, \quad \xi_{30} = 1.618, \quad \xi_{40} = 1.616. \quad (34)$$

### 3 Results and conclusions

The obtained solutions (32), (33) are sufficiently exact and can be used for theoretical calculations of impurities spreading by diffusion from a square window in semiconductors for the production of electronic devices. The nonlinear diffusion equation for two-dimensional case also was solved [12] and the following result for maximum similarities variables was obtained  $\xi_{10} = \xi_{20} = 0.429$ .

Our results can also be used for the heat transfer problem in solids from surfaces of materials heated with lasers [11]. The presented nonlinear equation can be applied to gasses [1] and solid states.

## References

- [1] B.F. Apostol. On a non-linear describing clouds and wreaths of smoke. *Phys. Lett. A*, **235**:363–366, 1997.
- [2] S. Balakauskas, A.J. Janavičius, V. Kzlauskienė, A. Mekys, R. Purlys and J. Storasta. Superdiffusion in Si crystal lattice irradiated by soft X-rays. *Acta Phys. Pol. A*, **114**:779–790, 2008.
- [3] V.V. Būda, D.J. Zanevičius and M.P. Sapagovas. Computational experimentt in nonlinear diffusion. *Mat. Comp. Modell. Microelectr.*, **MMMM-85**:36–42, 1984 (in Russian).
- [4] M.E. Glickman. *Diffusion in Solids*. Wiley, New York, 2000.
- [5] A.J. Janavičius. Method for solving the nonlinear diffusion equation. *Phys. Lett. A*, **224**:159–162, 1997.
- [6] A.J. Janavičius. The nonlinear diffusion in the nonisothermal case. *Acta Phys. Pol. A*, **93**:505–512, 1998.
- [7] A.J. Janavičius. Equations for nonlinear diffusion. *Liet. mat. rink. LMD darbai*, **51**:9–15, 2010.
- [8] A.J. Janavičius, S. Balakauskas and R. Purlys. Superdiffusion of phophorus in p-Si wafers irradiated by soft X-rays. In *The 13-th International Conference-School “Advanced Materials and Technologies”, 27–31 August, Palanga, Lithuania*, p. 129, Technologija, Kaunas, 2011.
- [9] A.J. Janavičius and Ž. Norgėla. Problem of uniqueness of the physical solution of nonlinear diffusion equation. *Physical Mathematical Faculty Works of Scientific Seminar*, **1**:5–9, 1998.
- [10] A.J. Janavičius, V. Stukaitė and D.J. Zanevičius. Similarity solution of diffusion equation for the case of diffusion coefficient depending on concentration. *Electr. Techn. Ser. 2: Semiconductor Dev.*, **160**:27–30, 1983 (in Russian).
- [11] A.J. Janavičius and S. Turskienė. Modeling of thermodiffusion inertia in metal films heated with ultrashort laser pulses. *Acta Phys. Pol. A*, **110**:511–521, 2006.
- [12] A.J. Janavičius and S. Turskienė. Nonlinear diffusion in a plane surface. *Can. J. Phys.*, **91**(12):1057–1061, 2013.
- [13] G.A. Korn and T.M. Korn. *Mathematical Handbook for Scientists and Engineers*. McGraw-Hill Book Co., New York, 1961.
- [14] W.-S. Wang and Y.-H. Lo. Profile estimation of high-concentration arsenic or boron diffusion in silicon. *IEEE Trans. Elektron Dev.*, **30**:1828–1831, 1983.

## REZIUMĖ

### Netiesinės difuzijos priklausomybė nuo dimensijų

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Straipsnyje nagrinėjami netiesinės difuzijos lygties sprendiniai vienmačiu ir trimačiu atvejais, pateikti maksimalūs priemaišų įsiskverbimo gyliai kietuose kūnuose. Nustatyti parametrai vienmačiam, dvimačiam ir trimačiam netiesinės difuzijos uždaviniui. Paprasto ryšio tarp difuzijos koeficientų kaip tiesinės difuzijos atveju negavome, bet yra galimybė pasirinkti prioritetines difuzijos sklidimo kryptis atsižvelgiant į kristalų struktūrą, aplinkos nehomogeniškumą.

*Raktiniai žodžiai*: netiesinė difuzijos lygtis, priemaišų įsiskverbimo gylis, difuzijos koeficientas, apytikslis analizinis sprendinys.